

FCC TEST REPORT

FCC ID : WSQLS-41JA

Applicant : Beijing Lanbe Tianhe Technologies&Develop CO., Ltd.

Address : Room 508,Guoxin Building,
SHOUT:Nan Rd. NO.20,Haidian District,Beijing,China

Equipment Under Test (EUT) :

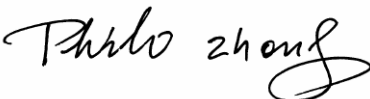
Product description : KVM SWITCH

Model No. : WSQLS-21JA, WSQLS-21JS,
WSQLS-41JA, WSQLS-41JS

Standards : FCC Part 15 Subpart B

Date of Test : Sep. 12, 2009

Test Engineer :Maikou.zhang

Reviewed By : 

Test Result :	PASS *
----------------------	---------------

PERPARED BY:

Waltek Services (Shenzhen) Co., Ltd.

1/F, Fukangtai Building, West Baima Rd., Songgang Street, Baoan District, Shenzhen
518105, China

Tel :+86-755-27553488

Fax:+86-755-27553868

1 Test Summary

Test	Test Requirement	Test Method	Class / Severity	Result
Radiated Emission (30MHz to 2GHz)	FCC PART 15, SUBPART B: 2007	ANSI C63.4: 2003	Class B	PASS
Conducted Emission (150KHz to 30MHz)	FCC PART 15, SUBPART B: 2007	ANSI C63.4: 2003	Class B	PASS

Contents

1	COVER PAGE	1
1	TEST SUMMARY.....	2
	CONTENTS	3
2	GENERAL INFORMATION	4
2.1	CLIENT INFORMATION	4
2.2	GENERAL DESCRIPTION OF E.U.T.	4
2.3	DETAILS OF E.U.T.....	4
2.4	DESCRIPTION OF SUPPORT UNITS	4
2.5	STANDARDS APPLICABLE FOR TESTING	4
2.6	TEST FACILITY	5
2.7	TEST LOCATION	5
3	EQUIPMENT USED DURING TEST	6
4	EMISSIONS TEST RESULTS	9
4.1	CONDUCTED EMISSION DATA	9
4.1.1	<i>E.U.T. Operation</i>	<i>9</i>
4.1.2	<i>EUT Setup.....</i>	<i>10</i>
4.1.3	<i>Conducted Emission Test Data.....</i>	<i>10</i>
4.1.4	<i>Photographs – Conducted Emission Test Setup</i>	<i>11</i>
4.2	RADIATION EMISSION DATA	12
4.2.1	<i>Measurement Uncertainty.....</i>	<i>12</i>
4.2.2	<i>EUT Setup.....</i>	<i>12</i>
4.2.3	<i>Spectrum Analyzer Setup</i>	<i>13</i>
4.2.4	<i>Test Procedure.....</i>	<i>13</i>
4.2.5	<i>Corrected Amplitude & Margin Calculation.....</i>	<i>14</i>
4.2.6	<i>Summary of Test Results</i>	<i>15</i>
4.2.7	<i>Photographs – Radiation Emission Test Setup.....</i>	<i>17</i>
5	PHOTOGRAPHS - CONSTRUCTIONAL DETAILS.....	18
5.1	EUT - FRONT VIEW(LS-41JA).....	18
5.2	EUT – BACK VIEW(LS-41JA)	18
5.3	EUT1 - OPEN VIEW(LS-41JA).....	19
5.4	PCB 1 -FRONT VIEW(LS-41JA).....	19
5.5	PCB 1 - BACK VIEW(LS-41JA).....	20
5.6	PCB 2 -FRONT VIEW(LS-41JA).....	20
5.7	PCB 2 - BACK VIEW(LS-41JA).....	21
	FCC ID LABEL	22

2 General Information

2.1 Client Information

Applicant: Beijing Lanbe Tianhe Technologies&Develop CO., Ltd.
Address of Applicant: Room 508,Guoxin Building,
SHOUT:Nan Rd. NO.20,Haidian District,Beijing,China

Manufacturer: Beijing Lanbe Tianhe Technologies&Develop CO., Ltd.
Address of manufacturer: Room 508,Guoxin Building,
SHOUT:Nan Rd. NO.20,Haidian District,Beijing,China

2.2 General Description of E.U.T.

Product description: KVM SWITCH
Model No.: WSQLS-21JA, WSQLS-21JS,
WSQLS-41JA, WSQLS-41JS

Model Differences.: The electrocircuit Schematic of the all mode are same except the appearance are different, the model LS-41JA is testing sample, and the final test data was shown in this test report.

2.3 Details of E.U.T.

Power Supply: Signa by USB and VGA port

2.4 Description of Support Units

The EUT has been tested as an independent unit.

2.5 Standards Applicable for Testing

The customer requested FCC tests for a KVM SWITCH. The standards used were FCC Part 15 Subpart B.

2.6 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

- **FCC – Registration No.: 880581**

Waltek Services(Shenzhen) Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 880581. June 24, 2008.

- **IC – Registration No.: IC7760A**

Waltek Services(Shenzhen) Co., Ltd. has been registered and fully described in a report filed with the Industry Canada. The acceptance letter from the Industry Canada is maintained in our files. Registration IC7760A, July 24, 2008.

2.7 Test Location

All Emissions tests were performed at:-

1/F, Fukangtai Building, West Baima Rd., Songgang Street, Baoan District, Shenzhen
518105, China

3 Equipment Used during Test

Equipment Name	Manufacturer Model	Equipment No	Internal No	Specification	Cal. Date	Due Date	Cert. No	Uncertainty
EMC Analyzer	Agilent/ E7405A	MY45114943	W2008001	9k-26.5GHz	Aug-09	Aug-10	Wws20081596	±1dB
Trilog Broadband Antenne 30-3000 MHz	SCHWARZB ECK MESS-ELEKTROM / VULB9163	336	W2008002	30-3000 MHz	Aug-09	Aug-10		±1dB
Broad-band Horn Antenna 1-18 GHz	SCHWARZB ECK MESS-ELEKTROM / VULB9163	667	W2008003	1-18GHz	Aug-09	Aug-10		f<10 GHz: ±1dB 10GHz<f<18 GHz: ±1.5dB
Broadband Preamplifier 0.5-18 GHz	SCHWARZB ECK MESS-ELEKTROM / BBV 9718	9718-148	W2008004	0.5-18GHz	Aug-09	Aug-10		±1.2dB
10m Coaxial Cable with N-male Connectors usable up to 18GHz,	SCHWARZB ECK MESS-ELEKTROM / AK 9515 H	-	-	-	Aug-09	Aug-10		-
10m 50 Ohm Coaxial Cable with N-plug, individual length, usable up to 3(5)GHz, Connector	SCHWARZB ECK MESS-ELEKTROM / AK 9513				Aug-09	Aug-10		
Positioning Controller	C&C LAB/ CC-C-IF				N/A	N/A		
Color Monitor	SUNSP0/ SP-14C				N/A	N/A		
Test Receiver	ROHDE&SC HWARZ/ ESPI	101155	W2005001	9k-3GHz	Aug-09	Aug-10	Wws20080942	±1dB
EMI Receiver	Beijingkehuan	KH3931		9k-1GHz	Aug-09	Aug-10		
Two-Line V-Network	ROHDE&SC HWARZ/ ENV216	100115	W2005002	50Ω/50μH	Aug-09	Aug-10	Wws20080941	±10%

Equipment Name	Manufacturer Model	Equipment No	Internal No	Specification	Cal. Date	Due Date	Cert. No	Uncertainty
Absorbing Clamp	ROHDE&SC HWARZ/ MDS-21	100205	W2005003	impandance50 Ω loss : 17 dB	Aug-09	Aug-10	Wws20080943	± 1 dB
10m 50 Ohm Coaxial Cable with N-plug,individual length,usable up to 3(5)GHz, Connectors	SCHWARZB ECK MESS-ELEKTROM / AK 9514				Aug-09	Aug-10		
Digital Power Analyzer	Em Test AG/Switzerland/ DPA 500	V0745103095	W2008012	Power: 2000VA Vol-range: 0-300V Freq_range: 10-80Hz	Aug-09	Aug-10	Wwd20081185	Voltage distinguish:0.025% Power_freq distinguish:0.02Hz
Power Source	Em Test AG/Switzerland/ ACS 500	V0745103096	W2008013	Vol-range: 0-300V Power_freq: 10-80Hz				
Electrostatic Discharge Simulator	Em Test AG/Switzerland/DITO	V0745103094	W2008005	Contact discharge: 500V-10KV Air discharge: 500V-16.5KV	Aug-09	Aug-10	Wwc20082400	7.5A current will be changed in $V_m=1.5V$
RF Generator	TESEQ GmbH/ NSG4070	25781	W2008008	Fraq-range: 9K-1GHz RF voltage: -60 dBm-+10dBm	Aug-09	Aug-10	Wws20081890	Power_freq distinguish0.1Hz RFelectricity distinguish 0.1 B
CDN M-Type	TESEQ GmbH/ CDN M016	25112	W2008009	Voltage correct factor 9.5 dB	Aug-09	Aug-10	Wwc20082396	150K-80MHz: ± 1 dB 80-230MHz:-2-+3dB
EM-Clamp	TESEQ GmbH/ KEMZ 801	25453	W2008010	Freq_range: 0.15-1000 MHz	Aug-09	Aug-10	Wwc20082397	0.3-400 MHz: ± 4 dB Other freq: ± 5 dB
Attenuator 6dB	TESEQ GmbH/ ATN6050	25365			Aug-09	Aug-10	Wws20081597	

Equipment Name	Manufacturer Model	Equipment No	Internal No	Specification	Cal. Date	Due Date	Cert. No	Uncertainty
All Modules Generator	SCHAFFNER/6150	34579	W2008006	voltage:200V-4.4KV Pulse current: 100A-2.2KA	Aug-09	Aug-10	Wwc20082401	voltage: $\pm 10\%$ Pulse current: $\pm 10\%$
Capacitive Coupling Clamp	SCHAFFNER/CDN 8014	25311			Aug-09	Aug-10	Wwc20082398	-
Signal and Data Line Coupling Network	SCHAFFNER/CDN 117	25627	W2008011	1.2/50 μ S	Aug-09	Aug-10	Wwc20082399	-
AC Power Supply	TONGYUN/DTDGC-4				Aug-09	Aug-10	Wws20080944	-
Exposure Level Tester ELT-400	Narda Safety TEST Solutions/2304/03	M-0155	w2008022	Test freq range: 1—400kHz	Aug-09	Aug-10	Wwd20081191	Test uncertainty : 1—120kHz: $\pm 1.83\%$, 120 kHz-400 kHz: $\pm 4.06\%$
Magnetic Field Probe 100cm ²	Narda Safety TEST Solutions/2300/90.10	M-1070	w2008021	Test freq range: 1—400kHz				Test uncertainty : 1Hz-10Hz: $\pm 16.2\%$, 10Hz - 120kHz: $\pm 2.2\%$, 120 kHz-400 kHz: $\pm 4.7\%$
Active Loop Antenna Charger 10kHz-30MHz	Beijing Dazhi / ZN30900A	-	-	10kHz-30MHz	Aug-09	Aug-10		$\pm 1\text{dB}$
Other								
Notebook	IBM	X31	/	/	/	/		
PC	acer	AG1720	/	/	/	/		
Moniter	viewsonic	S27996-1W	/	/	/	/		
K/B	DELL	L100	/	/	/	/		
Mouse	acer	M-UVACR1	/	/	/	/		

4 Emissions Test Results

4.1 Conducted Emission Data

Test Requirement:	FCC Part15.107 Class B
Test Method:	ANSI C63.4:2003
Frequency Range:	150kHz to 30MHz
Class:	Class B
Limit:	66-56 dB μ V between 0.15MHz & 0.5MHz 56 dB μ V between 0.5MHz & 5MHz 60 dB μ V between 5MHz & 30MHz
Detector:	Peak for pre-scan (9kHz Resolution Bandwidth) Quasi-Peak & Average if maximised peak within 6dB of Average Limit

4.1.1 E.U.T. Operation

Operating Environment:	
Temperature:	25.5 °C
Humidity:	51 % RH
Atmospheric Pressure:	1012 mbar
EUT Operation :	

The EUT was tested according to ANSI C63.4:2003. The frequency spectrum from 150kHz to 30MHz was investigated. The EUT was tested in working mode, It was pre-tested in Connected with one PC mode and four PC mode, the worse was Connected four PC mode, so the data was shown Connected four PC mode only.

The maximised peak emissions from the EUT was scanned and measured for both the Live and Neutral Lines. Quasi-peak & average measurements were performed if peak emissions were within 6dB of the average limit line.

4.1.2 EUT Setup

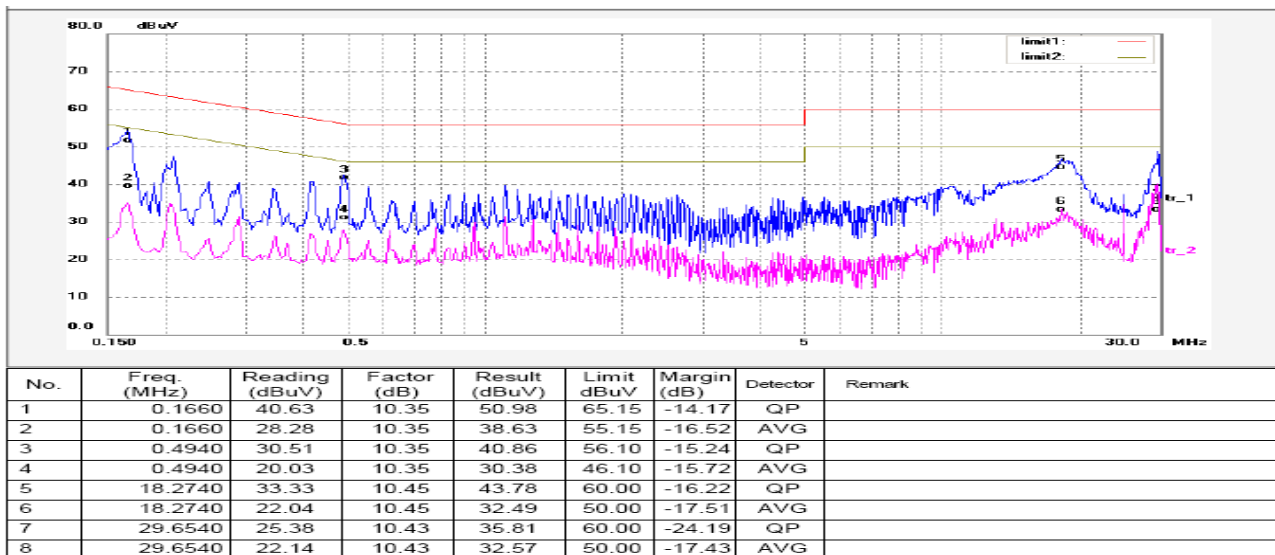
The conducted emission tests were performed using the setup accordance with the ANSI C63.4:2003, The specification used in this report was the FCC Part15.107 Class B limits.

The EUT was placed on the test table in working mode.

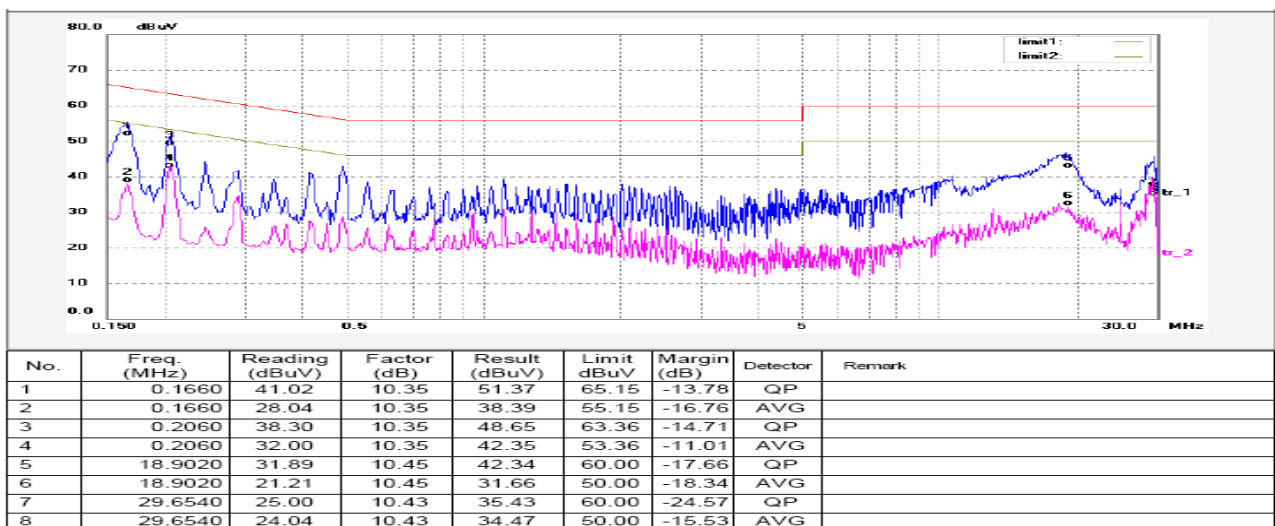
4.1.3 Conducted Emission Test Data

The conducted test data as below :

Live Line:



Neutral Line:



4.1.4 Photographs – Conducted Emission Test Setup



4.2 Radiation Emission Data

Test Requirement:	FCC Part15 B
Test Method:	Based on ANSI C63.4:2003
Frequency Range:	30MHz to 2GHz
Measurement Distance:	3m
Class:	Class B
Limit:	40.0 dB μ V/m between 30MHz & 88MHz 43.5 dB μ V/m between 88MHz & 216MHz 46.0 dB μ V/m between 216MHz & 960MHz 54.0 dB μ V/m above 960MHz
Detector:	Peak for pre-scan (120kHz resolution bandwidth) Quasi-Peak if maximised peak within 6dB of limit

4.2.1 Measurement Uncertainty

All measurements involve certain levels of uncertainties, especially in the field of EMC. The factors contributing to uncertainties are spectrum analyzer, cable loss, antenna factor calibration, antenna directivity, antenna factor variation with height, antenna phase center variation, antenna factor frequency interpolation, measurement distance variation, site imperfections, mismatch (average), and system repeatability.

Based on ANSI C63.4:2003, The Treatment of Uncertainty in EMC Measurements, the best estimate of the uncertainty of a radiation emissions measurement at Waltek EMC lab is ± 5.03 dB.

4.2.2 EUT Setup

The radiated emission tests were performed in the 3m Semi- Anechoic Chamber test site, using the setup accordance with the ANSI C63.4:2003, The specification used in this report was the FCC Part15 B limits.

4.2.3 Spectrum Analyzer Setup

According to FCC Part15 B Rules, the system was tested 30 to 2000MHz.

Below 1G

Start Frequency.....	30 MHz
Stop Frequency.....	1000 MHz
Sweep Speed	Auto
IF Bandwidth	120 kHz
Video Bandwidth.....	100KHz
Quasi-Peak Adapter Bandwidth	120 kHz
Quasi-Peak Adapter Mode	Normal
Resolution Bandwidth	100KHz

Above 1G

Start Frequency.....	1000 MHz
Stop Frequency.....	2000MHz
Sweep Speed	Auto
IF Bandwidth	120 kHz
Video Bandwidth.....	1MHz
Resolution Bandwidth	1MHz

4.2.4 Test Procedure

The radiated emissions test.

Maximizing procedure was performed on the six (6) highest emissions to ensure EUT is compliant with all installation combinations.

All data was recorded in the peak detection mode. Quasi-peak readings was performed only when an emission was found to be marginal (within -4 dBμV of specification limits), and are distinguished with a "**Qp**" in the data table.

The EUT was tested in working mode, It was pre-tested in Connected with one PC mode and four PC mode, the worse was Connected four PC mode, so the data was shown Connected four PC mode only.

4.2.5 Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain from the Amplitude reading. The basic equation is as follows:

$$\text{Corr. Ampl.} = \text{Indicated Reading} + \text{Antenna Factor} + \text{Cable Factor} - \text{Amplifier Gain}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of -7dBμV means the emission is 7dBμV below the maximum limit for Class B. The equation for margin calculation is as follows:

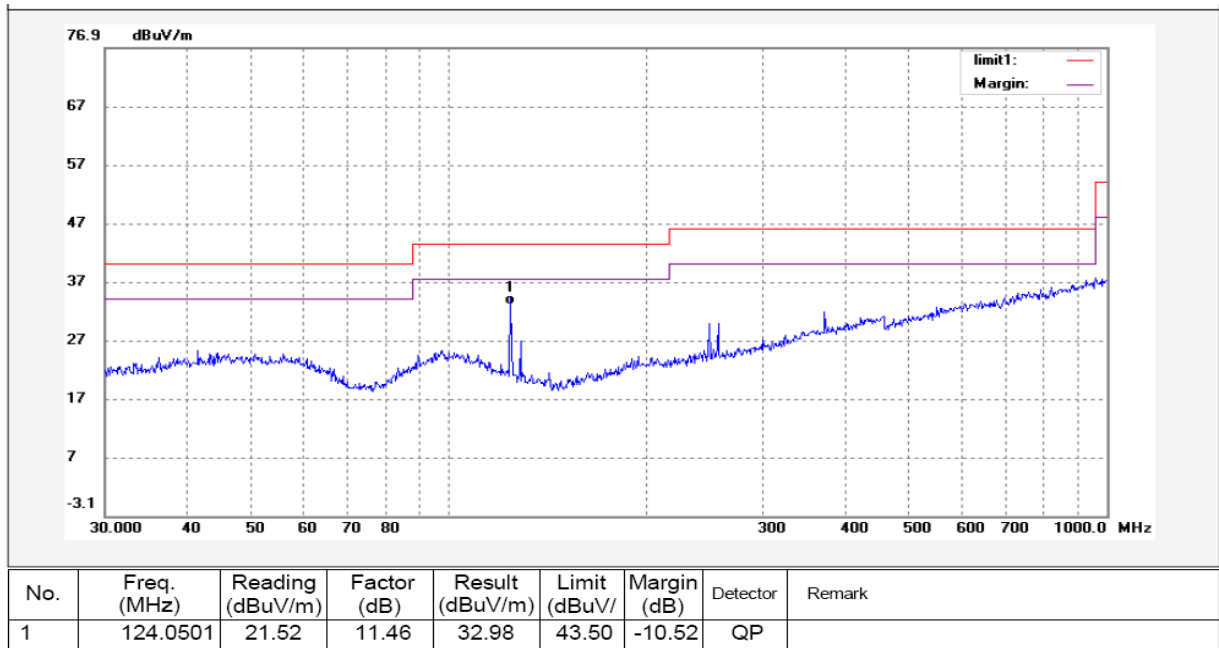
$$\text{Margin} = \text{Corr. Ampl.} - \text{Class B Limit}$$

4.2.6 Summary of Test Results

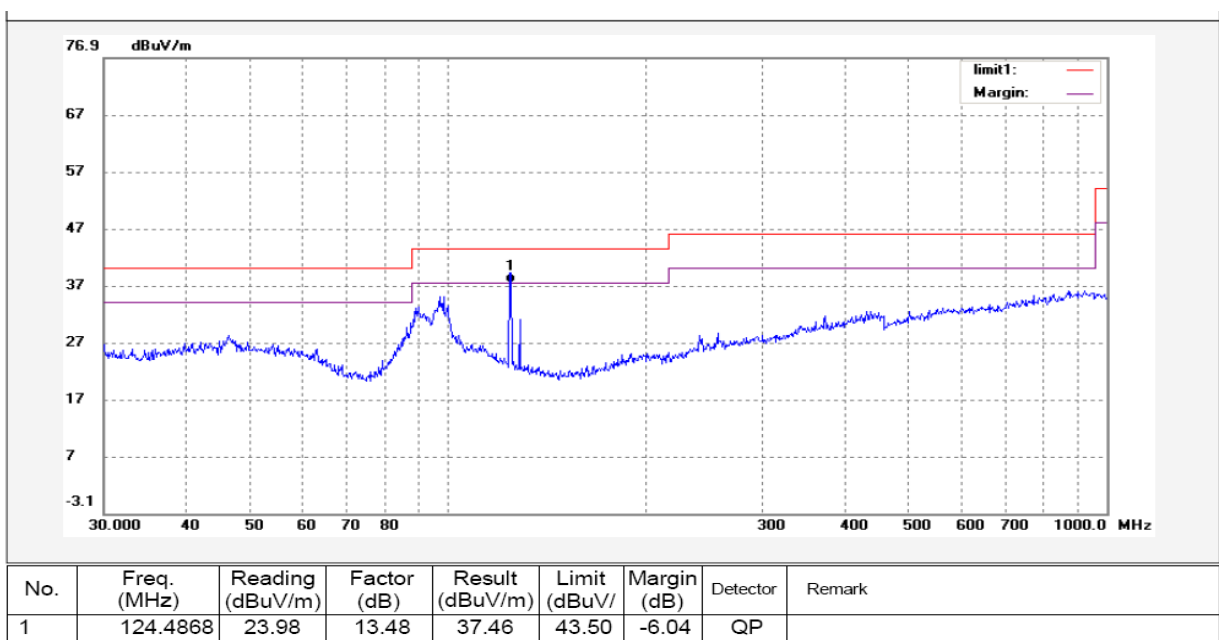
According to the data in this section, the EUT complied with the FCC Part15 B standards.

Below 1G

Test Antenna Polarization: **Horizontal**

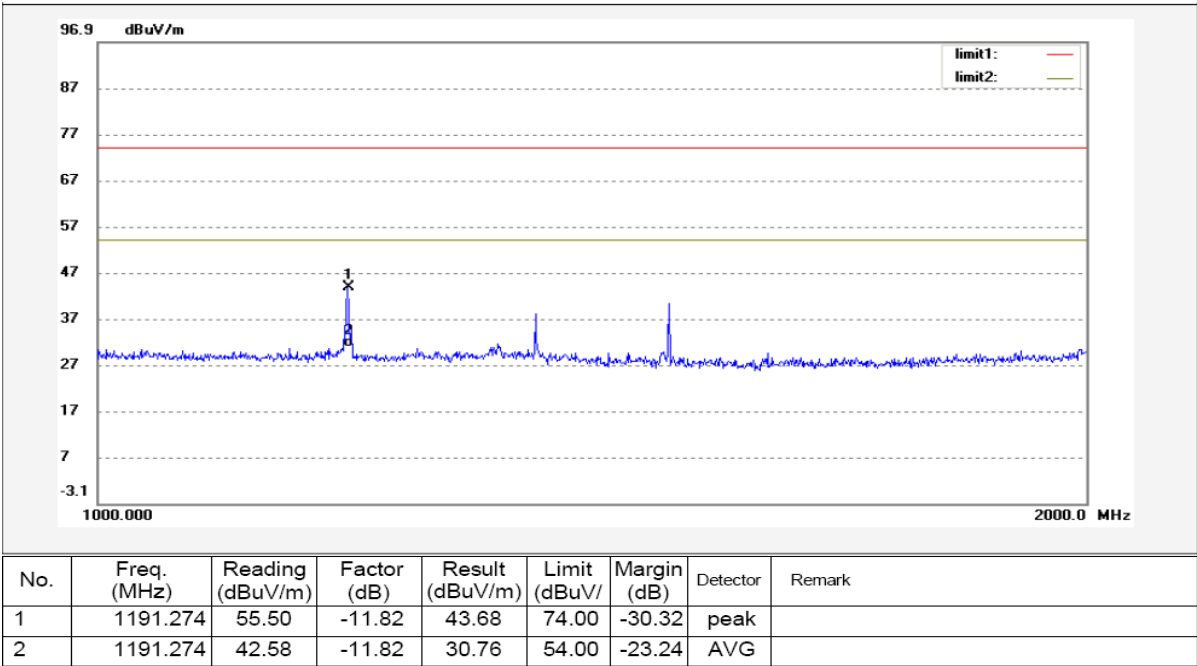


Test Antenna Polarization: **Vertical**

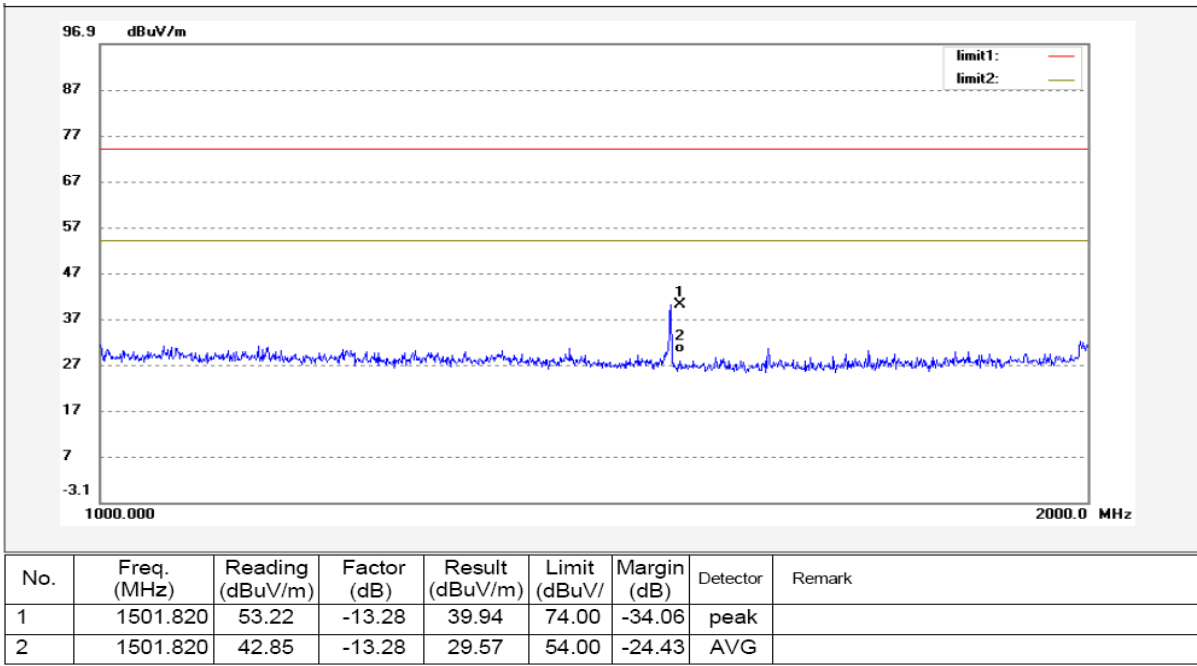


Above 1 G

Test Antenna Polarization: **Horizontal**



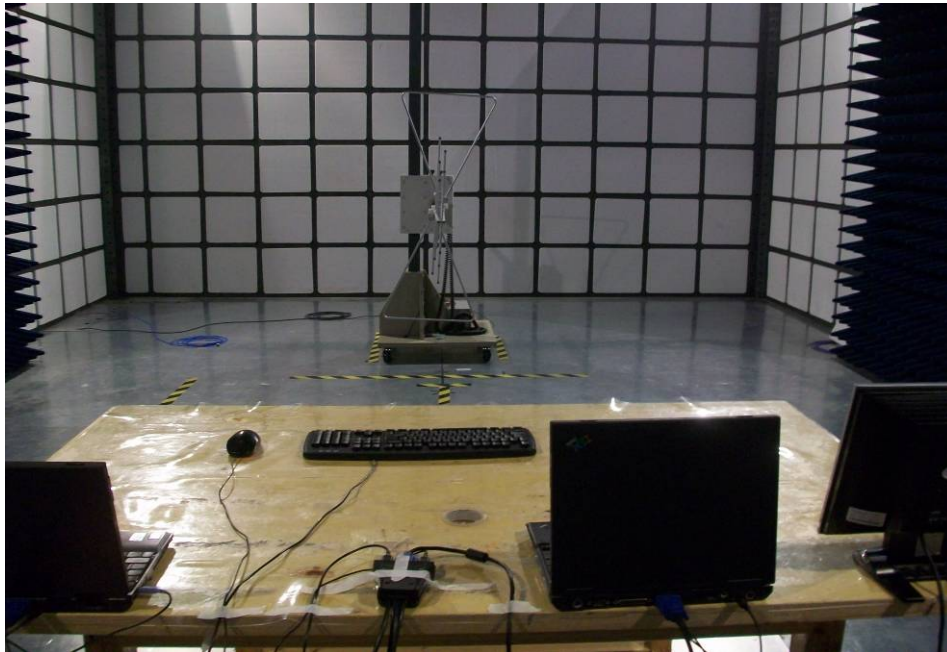
Test Antenna Polarization: **Vertical**



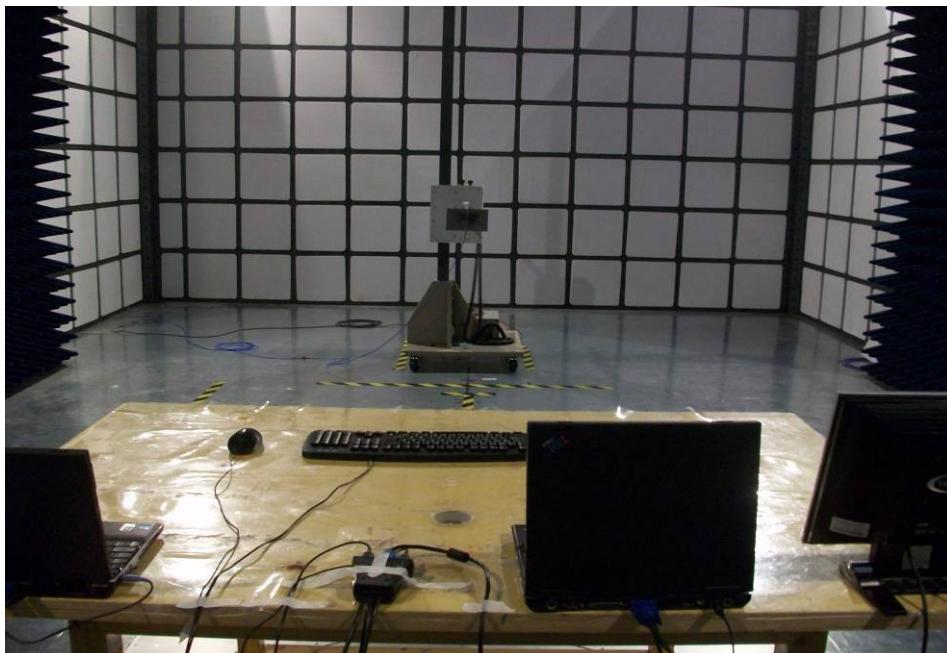
4.2.7 Photographs – Radiation Emission Test Setup

LS-41JA

Below 1G



Above 1G



5 Photographs - Constructional Details

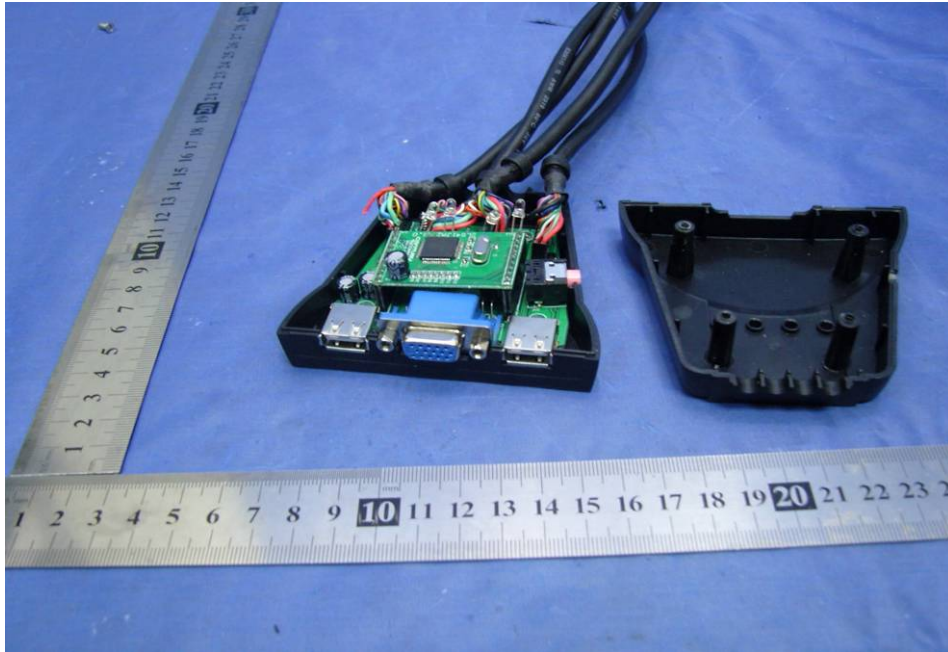
5.1 EUT - TopView(LS-41JA)



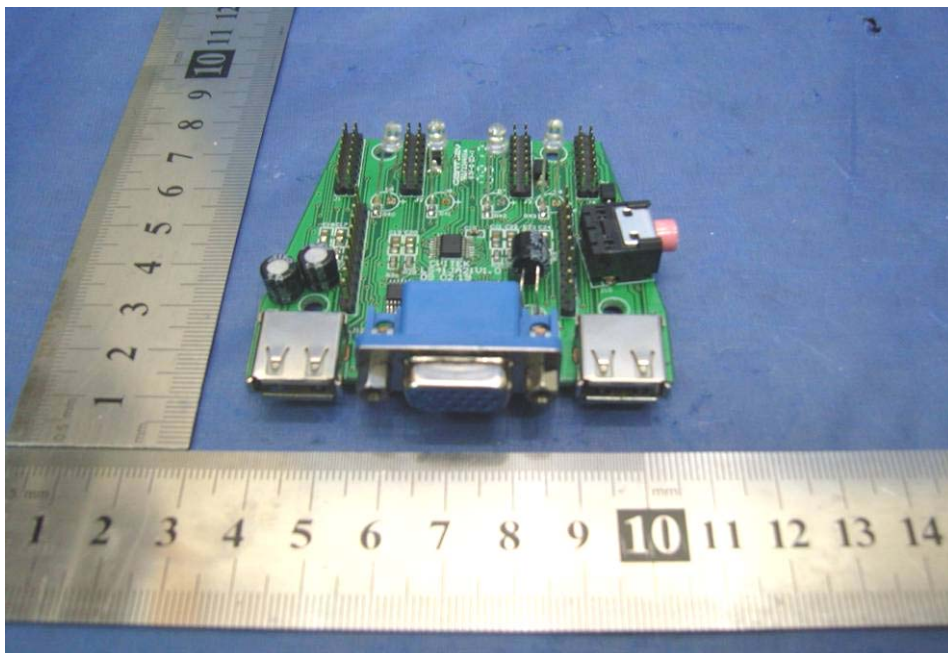
5.2 EUT –Bottom View(LS-41JA)



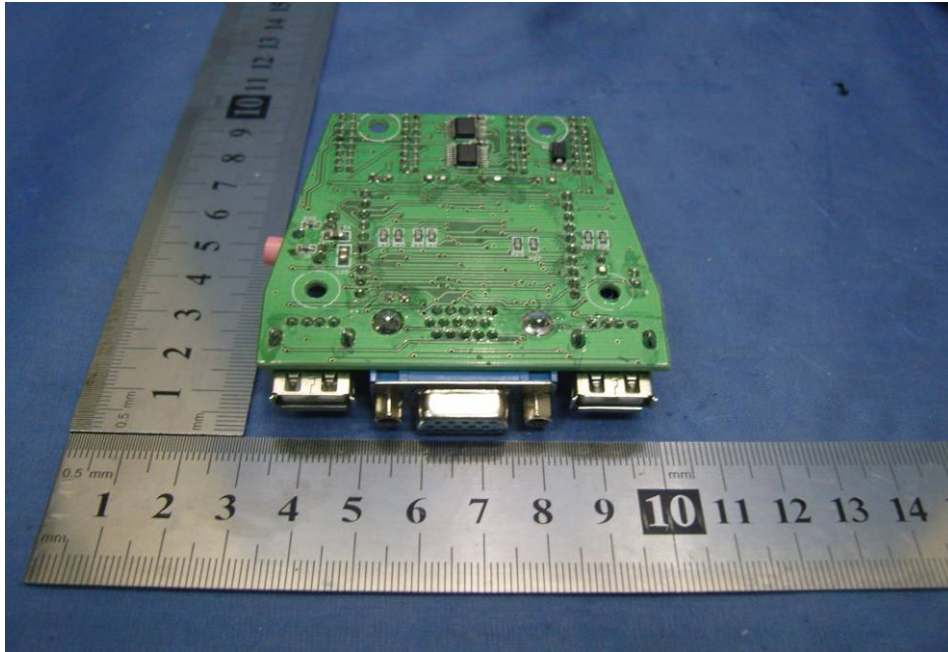
5.3 EUT1 - Open View(LS-41JA)



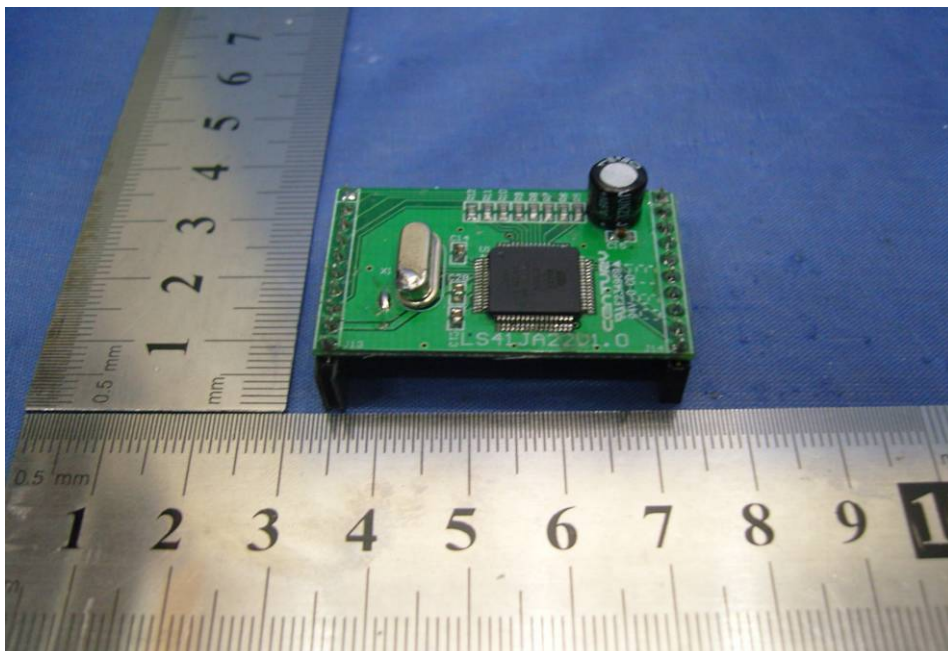
5.4 PCB 1 -Front View(LS-41JA)



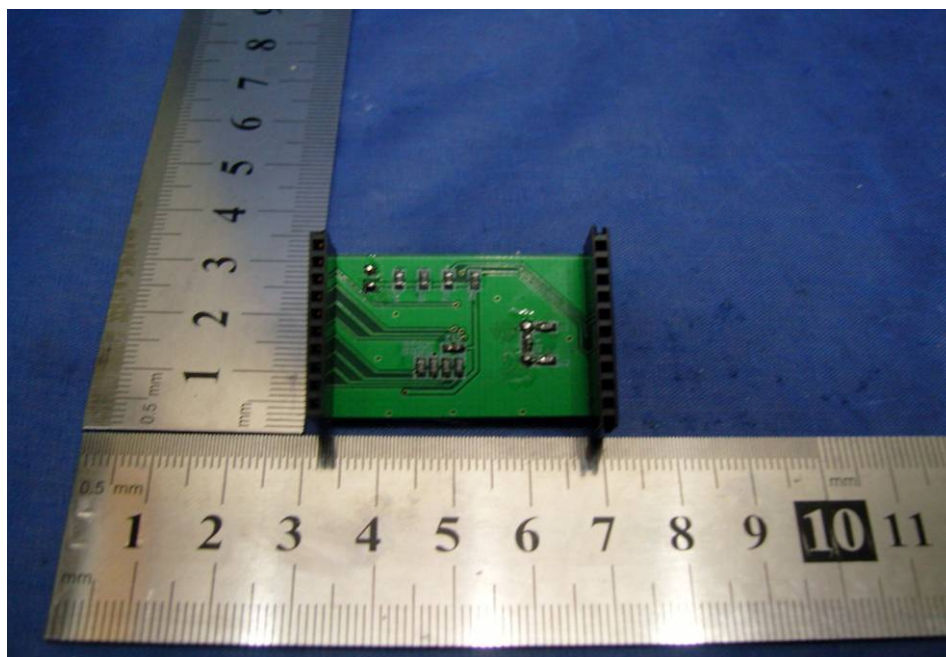
5.5 PCB 1 - Back View(LS-41JA)



5.6 PCB 2 -Front View(LS-41JA)



5.7 PCB 2 - Back View(LS-41JA)



FCC ID Label

This device complies with Part 15 of the FCC Rules. Operation is subject to the following two conditions:(1)this device may not cause harmful interference, and (2) this device must accept any interference received, including interference that may cause undesired operation.

The Label must not be a stick-on paper. The Label on these products must be permanently affixed to the product and readily visible at the time of purchase and must last the expected lifetime of the equipment not be readily detachable.

Proposed Label Location on EUT
EUT Top View/ proposed FCC Label Location

